

S101S05V Series

*Zero cross type is also available. (S101S06V Series/ S201S06V Series)

I_T(rms)≤3A, Non-Zero Cross type SIP 4pin **Triac output SSR**



Description

S101S05V Series Solid State Relays (SSR) are an integration of an infrared emitting diode (IRED), a Phototriac Detector and a main output Triac. These devices are ideally suited for controlling high voltage AC loads with solid state reliability while providing 3.0kV isolation (V_{iso}(rms)) from input to output.

Features

- 1. Output current, I_T(rms)≤3.0A
- 2. Non-zero crossing functionary
- 3.4 pin SIP package
- 4. High repetitive peak off-state voltage (V_{DRM} : 400V)
- 5. High isolation voltage between input and output $(V_{iso}(rms) : 3.0kV)$
- 6. Lead-free terminal components are also available (see Model Line-up section in this datasheet)
- 7. Screw hole for heat sink

Agency approvals/Compliance

- 1. Recognized by UL508, file No. E94758 (as models No. S101S05V)
- 2. Approved by CSA 22.2 No.14, file No. LR63705 (as models No. S101S05V)
- 3. Package resin : UL flammability grade (94V-0)

Applications

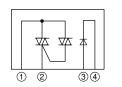
- 1. Isolated interface between high voltage AC devices and lower voltage DC control circuitry.
- 2. Switching motors, fans, heaters, solenoids, and valves.
- 3. Phase or power control in applications such as lighting and temperature control equipment.

Notice The content of data sheet is subject to change without prior notice

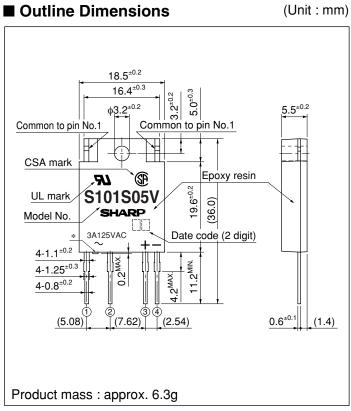
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Internal Connection Diagram



Output (Triac T2)
Output (Triac T1)
Input (+)
Input (-)



- * : Do not allow external connection.
- (): Typical dimensions



Date code (2 digit)

1st digit				2nd digit		
Year of production				Month of production		
A.D.	Mark	A.D	Mark	Month	Mark	
1990	A	2002	Р	January	1	
1991	В	2003	R	February	2	
1992	C	2004	S	March	3	
1993	D	2005	Т	April	4	
1994	Е	2006	U	May	5	
1995	F	2007	V	June	6	
1996	Н	2008	W	July	7	
1997	J	2009	Х	August	8	
1998	K	2010	А	September	9	
1999	L	2011	В	October	0	
2000	М	2012	С	November	N	
2001	N	:	:	December	D	

repeats in a 20 year cycle

Country of origin

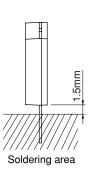
Japan

Rank mark

There is no rank mark indicator and currently there are no rank offered for this device.

Absolute Maximum Ratings

Absolute Maximum Ratings (T _a =25°C					
Parameter	Symbol	Rating	Unit		
Forward current	I _F	50 ^{*3}	mA		
Reverse voltage	VR	6	V		
RMS ON-state current	I _T (rms)	3 *3	A		
Peak one cycle surge current	Isurge	30 *4	A		
Repetitive		400			
peak OFF-state voltage	V DRM		V		
Non-Repetitive	X 7	400			
peak OFF-state voltage	V DSM	400	V		
Critical rate of rise of ON-state current	dI _T /dt	40	A/μs		
Operating frequency	f	45 to 65	Hz		
*1Isolation voltage		3.0	kV		
Operating temperature		-25 to +100	°C		
Storage temperature		-30 to +125	°C		
* ² Soldering temperature		260	°C		
	Parameter Forward current Reverse voltage RMS ON-state current Peak one cycle surge current Repetitive peak OFF-state voltage Non-Repetitive peak OFF-state voltage Critical rate of rise of ON-state current Operating frequency n voltage ng temperature temperature	ParameterSymbolForward currentIFReverse voltage V_R RMS ON-state currentIT(rms)Peak one cycle surge currentIsurgeRepetitive V_{DRM} peak OFF-state voltage V_{DRM} Non-Repetitive V_{DSM} Critical rate of rise of ON-state current dI_T/dt Operating frequencyfn voltage $V_{iso}(rms)$ ng temperature T_{opr} temperature T_{stg}	ParameterSymbolRatingForward currentIF 50^{*3} Reverse voltage V_R 6RMS ON-state currentIT(rms) 3^{*3} Peak one cycle surge currentIsurge 30^{*4} Repetitive V_{DRM} 400 peak OFF-state voltage V_{DRM} 400 Non-Repetitive V_{DSM} 400 Critical rate of rise of ON-state current dI_T/dt 40 Operating frequencyf 45 to 65 n voltage $V_{iso}(rms)$ 3.0 ng temperature T_{opr} -25 to $+100$ temperature T_{stg} -30 to $+125$		



*1 40 to 60%RH, AC for 1minute, f=60Hz *2 For 10s

*3 Refer to Fig.1, Fig.2 *4 f=60Hz sine wave, T_j=25°C start

Electro-optical Characteristics

Eleo	ctro-optical Characteristics					Γ)	$\Gamma_a=25^{\circ}C)$
	Parameter		Conditions	MIN.	TYP.	MAX.	Unit
T	Forward voltage	V _F	I _F =20mA	-	1.2	1.4	V
Input	Reverse current	I _R	V _R =3V	-	_	100	μΑ
	Repetitive peak OFF-state current	I _{DRM}	$V_D = V_{DRM}$	_	-	100	μΑ
Output	ON-state voltage	V _T (rms)	I_T (rms)=1.5A, Resistance load, I_F =20mA	-	-	1.5	V
	Holding current	I _H	_	-	-	50	mA
	Critical rate of rise of OFF-state voltage	dV/dt	$V_D=2/3 \bullet V_{DRM}$	30	-	-	V/µs
	Critical rate of rise of OFF-state voltage at commutaion	(dV/dt)c	$T_j=125^{\circ}C, V_D=2/3 \cdot V_{DRM}, dI_T/dt=-1.5A/ms$	4	-	-	V/µs
Transfer charac- teristics	Minimum trigger current	I _{FT}	$V_D=12V, R_L=30\Omega$	_	-	15	mA
	Isolation resistance	R _{ISO}	DC500V, 40 to 60%RH	1010	-	-	Ω
	Turn-on time	t _{on}	V _D (rms)=100V, AC50Hz,	_	_	1	ms
	Turn-off time	t _{off}	$I_T(rms)=1.5A$, Resistance load, $I_F=20mA$	_	_	10	ms
Theorem		R _{th} (j-c)	Between junction and case	-	6	-	°C/W
Thermal resistance		R _{th} (j-a)	Between junction and ambient	_	45	_	1 U/W

■ Model Line-up (1) (Lead-free terminal components)

Shipping Package	Case	V _{DRM}	$I_{FT}[mA]$		
	200pcs/case	[V]	$(V_D=12V, R_L=30\Omega)$		
Model No.	S101S05F	400	MAX.15		

■ Model Line-up (2) (Lead solder plating components)

Shipping Package	Case	V _{DRM}	$I_{FT}[mA]$		
	200pcs/case	[V]	$(V_D=12V, R_L=30\Omega)$		
Model No.	S101S05V	400	MAX.15		

Please contact a local SHARP sales representative to see the actual status of the production.

Fig.1 Forward Current vs. Ambient Temperature

SHARP

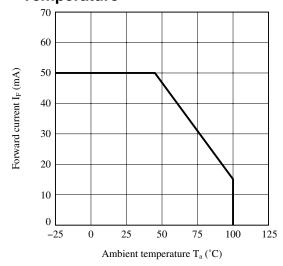
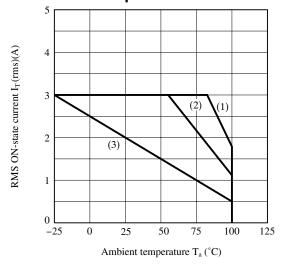
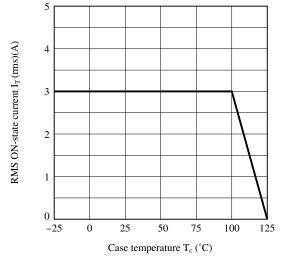


Fig.2 RMS ON-state Current vs. Ambient Temperature







- (1) With heat sink (100×100×2mm Al plate)
- (2) With heat sink (50×50×2mm Al plate)
 - (3) Without heat sink
- (Note) In natural cooling condition, please locate Al plate vertically, spread the thermal conductive silicone grease on the touch surface of the device and tighten up the device in the center of Al plate at the torque of 0.4N • m.

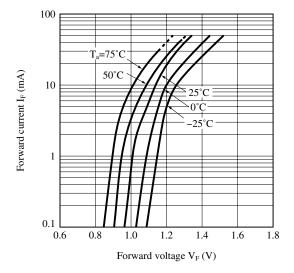
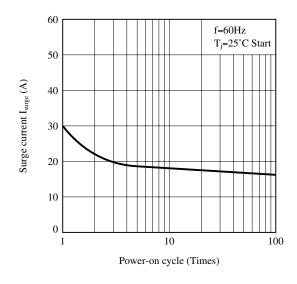


Fig.4 Forward Current vs. Forward Voltage



Fig.5 Surge Current vs. Power-on Cycle





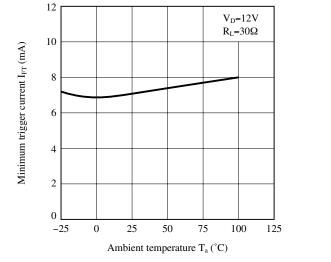


Fig.6 Maximum ON-state Power Dissipation vs. RMS ON-state Current

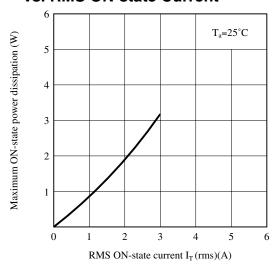
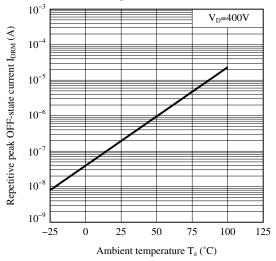


Fig.8 Repetitive Peak OFF-state Current vs. Ambient Temperature



Remarks : Please be aware that all data in the graph are just for reference.



Design Considerations

Recommended Operating Conditions

Parameter		Symbol	Conditions	MIN.	MAX.	Unit
Input	Input signal current at ON state	I _F (ON)	_	25	35	mA
	Input signal current at OFF state	I _F (OFF)	_	0	0.1	mA
Output	Load supply voltage	V _{OUT} (rms)	_	80	120	V
	Load supply current	I _{OUT} (rms)	Locate snubber circuit between output terminals	0.1	I _T (rms)	mA
	Load supply current		(Cs=0.022μF, Rs=47Ω)	0.1	×80%(*)	
	Frequency	f	_	47	63	Hz
Operating temperature		T _{opr}	_	-20	80	°C

(*) See Fig.2 about derating curve (I $_{\rm T}({\rm rms})$ vs. ambient temperature).

• Design guide

In order for the SSR to turn off, the triggering current (I_F) must be 0.1mA or less.

In phase control applications or where the SSR is being by a pulse signal, please ensure that the pulse width is a minimum of 1ms.

When the input current (I_F) is below 0.1mA, the output Triac will be in the open circuit mode. However, if the voltage across the Triac, V_D, increases faster than rated dV/dt, the Triac may turn on. To avoid this situation, please incorporate a snubber circuit. Due to the many different types of load that can be driven, we can merely recommend some circuit vales to start with : Cs=0.022 μ F and Rs=47 Ω . The operation of the SSR and snubber circuit should be tested and if unintentional switching occurs, please adjust the snubber circuit component values accordingly.

When making the transition from On to Off state, a snubber circuit should be used ensure that sudden drops in current are not accompanied by large instantaneous changes in voltage across the Triac. This fast change in voltage is brought about by the phase difference between current and voltage. Primarily, this is experienced in driving loads which are inductive such as motors and solenoids. Following the procedure outlined above should provide sufficient results.

Any snubber or Varistor used for the above mentioned scenarios should be located as close to the main output triac as possible.

The load current should be within the bounds of derating curve. (Refer to Fig.2) Also, please use the optional heat sink when necessary.

In case the optional heat sink is used and the isolation voltage between the device and the optional heat sink is needed, please locate the insulation sheet between the device and the heat sink.

When the optional heat sink is equipped, please set up the M3 screw-fastening torque at 0.3 to 0.5N•m. In order to dissipate the heat generated from the inside of device effectively, please follow the below suggestions.

- (a) Make sure there are no warps or bumps on the heat sink, insulation sheet and device surface.
- (b) Make sure there are no metal dusts or burrs attached onto the heat sink, insulation sheet and device surface.
- (c) Make sure silicone grease is evenly spread out on the heat sink, insulation sheet and device surface.



Silicone grease to be used is as follows;

- 1) There is no aged deterioration within the operating temperature ranges.
- 2) Base oil of grease is hardly separated and is hardly permeated in the device.
- 3) Even if base oil is separated and permeated in the device, it should not degrade the function of a device.

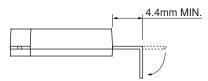
Recommended grease : G-746 (Shin-Etsu Chemical Co., Ltd.)

: G-747 (Shin-Etsu Chemical Co., Ltd.)

: SC102 (Dow Corning Toray Silicone Co., Ltd.)

In case the optional heat sink is screwed up, please solder after screwed.

In case of the lead frame bending, please keep the following minimum distance and avoid any mechanical stress between the base of terminals and the molding resin.



Some of AC electromagnetic counters or solenoids have built-in rectifier such as the diode. In this case, please use the device carefully since the load current waveform becomes similar with rectangular waveform and this results may not make a device turn off.

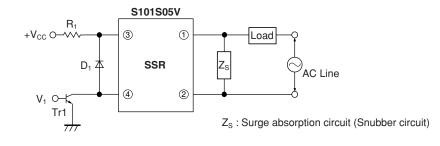
Degradation

In general, the emission of the IRED used in SSR will degrade over time.

In the case where long term operation and / or constant extreme temperature fluctuations will be applied to the devices, please allow for a worst case scenario of 50% degradation over 5years.

Therefore in order to maintain proper operation, the initial triggering current should be designed in consideration of degradation.

Standard Circuit



☆ For additional design assistance, please review our corresponding Optoelectronic Application Notes.



Manufacturing Guidelines

Soldering Method

Flow Soldering (No solder bathing) Flow soldering should be completed below 260°C and within 10s. Preheating is within the bounds of 100 to 150°C and 30 to 80s. Please solder within one time.

Other notices

Please test the soldering method in actual condition and make sure the soldering works fine, since the impact on the junction between the device and PCB varies depending on the tooling and soldering conditions.



• Cleaning instructions

Solvent cleaning :

Solvent temperature should be 45°C or below. Immersion time should be 3minutes or less.

Ultrasonic cleaning :

The impact on the device varies depending on the size of the cleaning bath, ultrasonic output, cleaning time, size of PCB and mounting method of the device.

Therefore, please make sure the device withstands the ultrasonic cleaning in actual conditions in advance of mass production.

Recommended solvent materials :

Ethyl alcohol, Methyl alcohol and Isopropyl alcohol.

In case the other type of solvent materials are intended to be used, please make sure they work fine in actual using conditions since some materials may erode the packaging resin.

Presence of ODC

This product shall not contain the following materials.

And they are not used in the production process for this device.

Regulation substances : CFCs, Halon, Carbon tetrachloride, 1.1.1-Trichloroethane (Methylchloroform) Specific brominated flame retardants such as the PBBOs and PBBs are not used in this product at all.



Package specification

Package materials

Packing case : Corrugated cardboard Partition : Corrugated cardboard Pad : Corrugated cardboard Cushioning material : Polyethylene Molt plane : Urethane

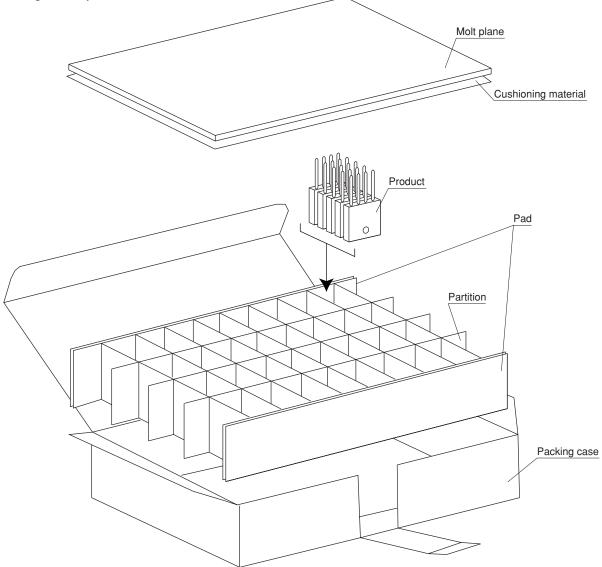
Package method

The product should be located after the packing case is partitioned and protected inside by 4 pads.

Each partition should have 5 products with the lead upward.

Cushioning material and molt plane should be located after all products are settled (1 packing contains 200 pcs).

Package composition



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- --- Personal computers
- --- Office automation equipment
- --- Telecommunication equipment [terminal]
- --- Test and measurement equipment
- --- Industrial control
- --- Audio visual equipment
- --- Consumer electronics

(ii) Measures such as fail-safe function and redundant design should be taken to ensure reliability and safety when SHARP devices are used for or in connection with equipment that requires higher reliability such as:

- --- Transportation control and safety equipment (i.e., aircraft, trains, automobiles, etc.)
- --- Traffic signals
- --- Gas leakage sensor breakers
- --- Alarm equipment
- --- Various safety devices, etc.

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- --- Telecommunication equipment [trunk lines]
- --- Nuclear power control equipment
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